Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/762,424	HAYASHI, MORIHIKO	
Examiner	Art Unit	
Kevin Mew	2616	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
370/328-329, 335 370/ 348, 431-432 370/437, 441-443, 458-459 (Text search only - see search history printout)	7/27/2006	КМ		